

# Test report

**Customer:**

Identive GmbH.  
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85737 Ismaning  
Tel.: +49 89 9595-5000  
Fax: +49 89 9595-5555

## EMC test report 120276-AU01+E01



**Identive GmbH**  
**USB Contact Card Reader**  
CLOUD 2700 F



The test results refer exclusively  
to the model tested.

This report must not be copied without  
the written authorization by the lab.  
Revision: 1.3



# EMV **TESTHAUS** GmbH

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Accreditation:



Location of Testing:

EMV **TESTHAUS** GmbH  
Gustav-Hertz-Straße 35  
94315 Straubing

The technical accuracy is guaranteed through the quality management of the  
EMV **TESTHAUS** GmbH.



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CLOUD 2700 F

120276-AU01+E01

Page 2 of 32

# Table of contents

1. Test regulation .....	4
2. Equipment under test .....	8
3. Test configuration and mode of operation .....	10
4. Measurement of conducted emission.....	11
5. Measurement of radiated emission .....	18
6. Electrostatic discharge immunity test .....	23
7. Radiated, radio-frequency, electromagnetic field immunity test .....	27
8. Measurement uncertainty .....	31
9. Summary .....	32



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CLOUD 2700 F

120276-AU01+E01

Page 3 of 32

# 1. Test regulation

## Emission

EN 55022:2010  
+AC:2011

Information technology equipment Radio  
disturbance characteristics –  
Limits and methods of measurement

☐ Class A:

Class A ITE is a category of all other ITE which satisfies the Class A ITE limits but not the Class B ITE limits. Such equipment should not be restricted in its sale but the following warning shall be included in the instructions for use.

Warning:

This is a class A product. In a domestic environment this product may cause radio interferences in which case the user may be required to take adequate measures.

☒ Class B

Class B ITE is a category of apparatus which satisfies the class B disturbance limits. Class B ITE is intended primarily for use in the domestic environment and may include

- equipment with no fixed place of use; for example portable equipment powered by built-in batteries;
- telecommunication terminal equipment powered by a telecommunication network;
- personal computers and auxiliary connected equipment.



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CLOUD 2700 F

120276-AU01+E01

Page 4 of 32

**Includes the following tests:**

Measurement of the conducted disturbance at mains ports in a frequency range from 150 kHz to 30 MHz.

Measurement of the conducted common mode disturbance at telecommunication ports in a frequency range from 150 kHz to 30 MHz.

Measurement of radiated disturbance in a frequency range from 30 MHz to 1GHz.

Measurement of radiated disturbance in a frequency range from 1GHz to max. 6 GHz.

**Emission in the frequency range of  $\leq 2$  kHz:**

EN 61000-3-2:2006  
+ A1:2009  
+ A2:2009

Harmonic current emissions  
(equipment input current  $\leq 16$  A per phase)

EN 61000-3-3:2008

Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current  $\leq 16$  A

Deviation of regulations and standards: No



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CLOUD 2700 F

120276-AU01+E01

Page 5 of 32

## Susceptibility

EN 55024:2010

Information technology equipment -  
Immunity characteristics

Includes Basic EMC  
Publications:

EN 61000-4-2:2009

Testing and measurement techniques -  
Electrostatic discharge immunity test.

EN 61000-4-3:2006  
+A1:2008  
+A2:2010

Testing and measurement techniques -  
Radiated, radio frequency, immunity test.

EN 61000-4-4:2004  
+A1:2010

Testing and measurement techniques -  
Electrical fast transient (EFT)/burst immunity test.

EN 61000-4-5:2006

Testing and measurement techniques -  
Surge immunity test.

EN 61000-4-6:2009

Testing and measurement techniques -  
Immunity to conducted disturbances, induced by  
radio-frequency fields.

EN 61000-4-8:2010

Testing and measurement techniques -  
Power frequency magnetic field immunity test.

EN 61000-4-11:2004

Testing and measurement techniques -  
Voltage dips, short interruptions and voltage  
variations immunity tests.

Deviation of Regulation and Standards: No



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CLOUD 2700 F

120276-AU01+E01

Page 6 of 32

## Not applied tests:

EN 55022:2010  
+AC:2011

Measurement of radiated disturbance in a frequency range from 1GHz to max. 6 GHz.

Remark:

Pursuant to customer information the EUT has no internal frequencies above 108MHz.

EN 55022:2010  
+AC:2011

Measurement of the conducted common mode disturbance at telecommunication ports in a frequency range from 150 kHz to 30 MHz.

Remark:

The EUT has no telecommunication ports.

EN 61000-3-2:2006  
+A1:2009  
+A2:2009

Harmonic current emissions  
(equipment input current  $\leq 16$  A per phase)

EN 61000-3-3:2008

Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current  $\leq 16$  A.

EN 61000-4-8:2010

Testing and measurement techniques -  
Power frequency magnetic field immunity test.

Remark:

Only for equipment containing devices susceptible to magnetic fields.

EN 61000-4-11:2004

Testing and measurement techniques -  
Voltage dips, short interruptions and voltage variations immunity tests.

EN 61000-4-6:2009

Testing and measurement techniques -  
Immunity to conducted disturbances, induced by radio-frequency fields.

EN 61000-4-5:2006

Testing and measurement techniques -  
Surge immunity test.

EN 61000-4-4:2004  
+A1:2010

Testing and measurement techniques -  
Electrical fast transient (EFT)/burst immunity test.

Remark:

The EUT is USB powered.



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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 7 of 32

## 2. Equipment under test

Product type: USB Contact Card Reader

Model name: CLOUD 2700 F

Serial number: 5399YYWWMNNNNN

Manufacturer: Identive GmbH.

Operational description of the EUT: Continuously reading



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CLOUD 2700 F

120276-AU01+E01

Page 8 of 32



## Photo documentation



Picture 1: EUT

### 3. Test configuration and mode of operation

#### Test configuration

Numbers:	Description:	Serial No.:
1	EUT: Identive CLOUD 2700 F	5399YYWWMNNNN
1	Fujitsu test notebook	N/A
1	Identive chip card	N/A

#### Mode of operation

The EUT was tested in the following mode of operation:

Settings: Continuously reading

Applied Software: CE Test V1.0.0, build 1

Failure criterion for test of immunity from disturbances:

It was observed whether the EUT is influenced in any form or program interruptions occurred.



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CLOUD 2700 F

120276-AU01+E01

Page 10 of 32

## 4. Measurement of conducted emission

according to EN 55022 Class B

### Location of measurement

Description	Manufacturer	Inventory No.
Shielded chamber	Siemens - Matsushita	E00107

### Measurement equipment

	Description	Manufacturer	Inventory No.
<input type="checkbox"/>	ESH 3	Rohde & Schwarz	E00007
<input type="checkbox"/>	ESCS 30	Rohde & Schwarz	E00003
<input type="checkbox"/>	ESCI	Rohde & Schwarz	E00001
<input checked="" type="checkbox"/>	ESU	Rohde & Schwarz	W00002
<input type="checkbox"/>	ESH3 Z2	Rohde & Schwarz	E00028
<input type="checkbox"/>	ESH 2-Z5	Rohde & Schwarz	E00004
<input checked="" type="checkbox"/>	ESH 2-Z5	Rohde & Schwarz	E00005
<input type="checkbox"/>	ENY 41	Rohde & Schwarz	E00041
<input type="checkbox"/>	ENY 22	Rohde & Schwarz	E00042
<input type="checkbox"/>	ISN LAN	EMV <b>TESTHAUS</b> GmbH	E00357

Test related measurement inaccuracies have to be taken into consideration when evaluating the test results.  
All used test instrument as well as the test accessories are calibrated at regular intervals.



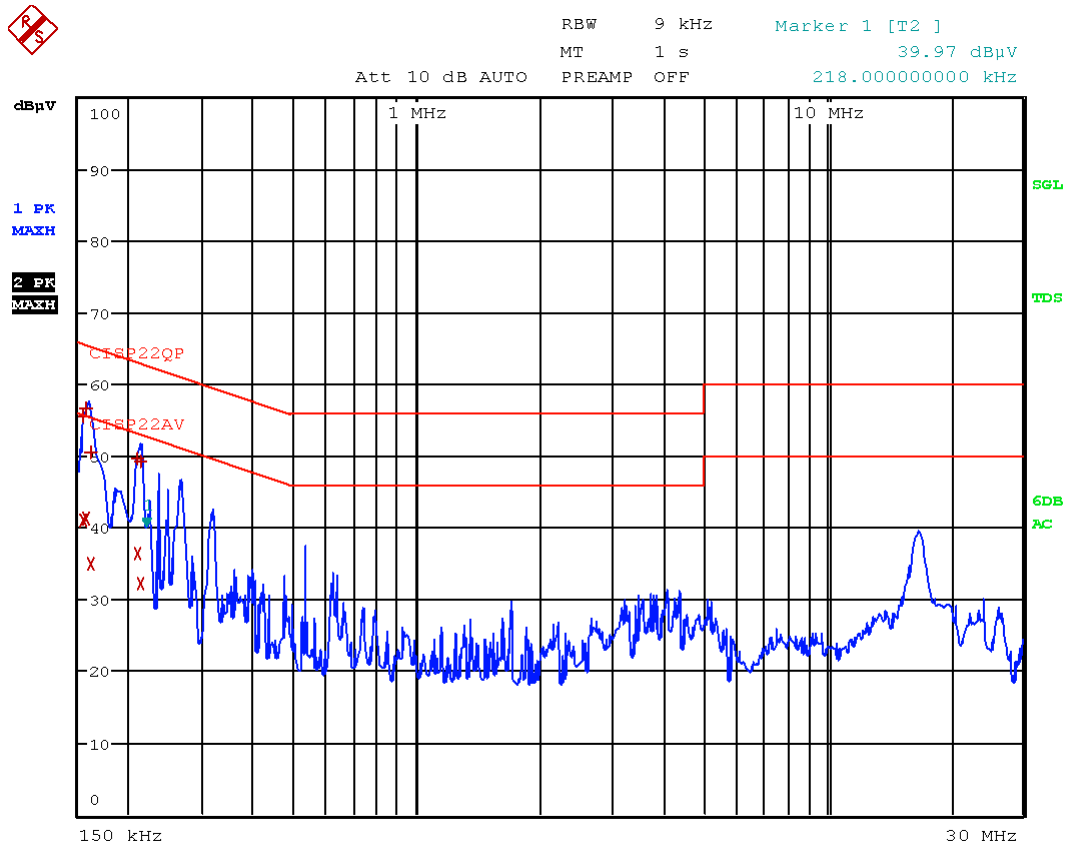
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CLOUD 2700 F

120276-AU01+E01

Page 11 of 32



Picture 2: Measurement report of conducted emission (phase L1)



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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 12 of 32

Trace	Frequency	Level (dBuV)	Detector	Delta Limit/dB
2	154.000000000 kHz	41.04	Average	-14.74
1	154.000000000 kHz	55.66	Quasi-Peak	-10.12
2	158.000000000 kHz	41.19	Average	-14.38
1	158.000000000 kHz	56.62	Quasi-Peak	-8.95
2	162.000000000 kHz	34.90	Average	-20.46
1	162.000000000 kHz	50.62	Quasi-Peak	-14.74
2	210.000000000 kHz	36.41	Average	-16.80
1	210.000000000 kHz	49.73	Quasi-Peak	-13.48
2	214.000000000 kHz	32.35	Average	-20.70
1	214.000000000 kHz	49.29	Quasi-Peak	-13.76

Picture 3: Frequency table of conducted emission (Phase L1)



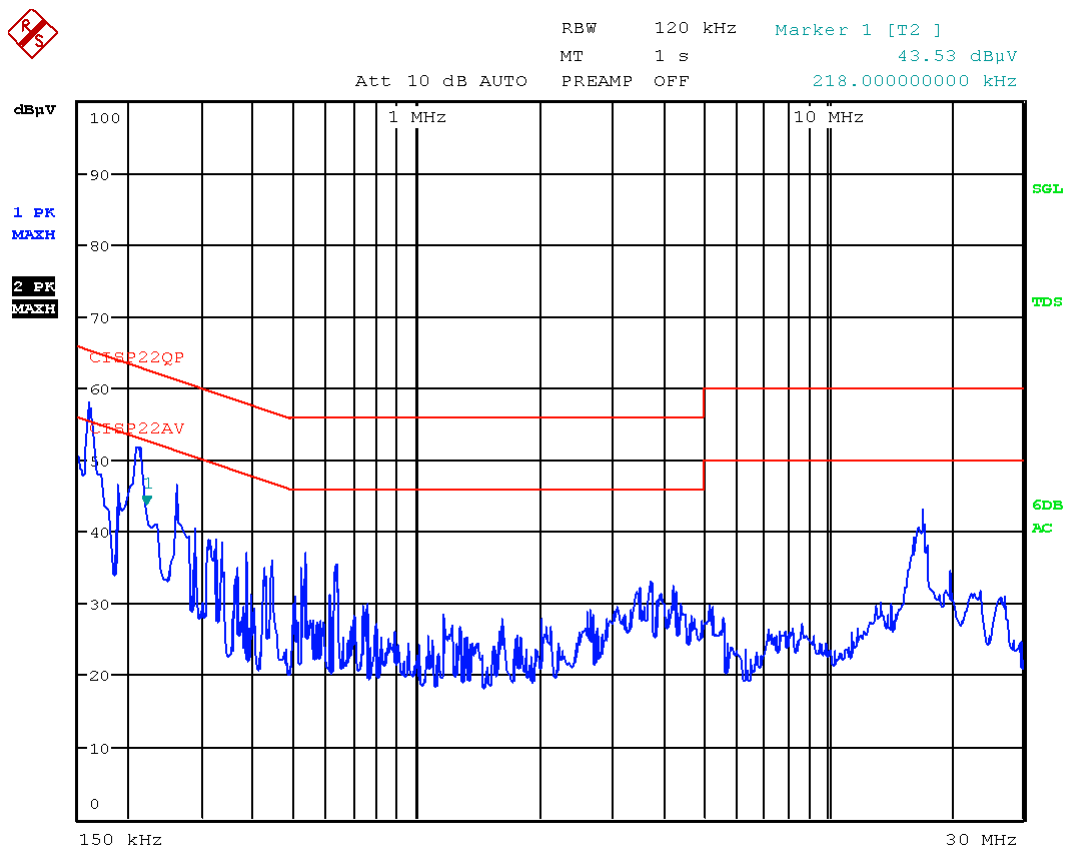
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CLOUD 2700 F

120276-AU01+E01

Page 13 of 32



Picture 4: Measurement report of conducted emission (Neutral N)



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Revision: 1.3

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CLOUD 2700 F

120276-AU01+E01

Page 14 of 32

Trace	Frequency	Level (dBμV)	Detector	Delta Limit/dB
2	154.000000000 kHz	41.04	Average	-14.74
1	154.000000000 kHz	55.66	Quasi-Peak	-10.12
2	158.000000000 kHz	41.19	Average	-14.38
1	158.000000000 kHz	56.62	Quasi-Peak	-8.95
2	162.000000000 kHz	34.90	Average	-20.46
1	162.000000000 kHz	50.62	Quasi-Peak	-14.74
2	210.000000000 kHz	36.41	Average	-16.80
1	210.000000000 kHz	49.73	Quasi-Peak	-13.48
2	214.000000000 kHz	32.35	Average	-20.70
1	214.000000000 kHz	49.29	Quasi-Peak	-13.76

Picture 5: Frequency table of conducted emission (Neutral N)



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CLOUD 2700 F

120276-AU01+E01

Page 15 of 32

## Photo documentation



Picture 6: Test setup conducted emission



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CLOUD 2700 F

120276-AU01+E01

Page 16 of 32



## Test result

The requirements according to EN 55022 Class B are

☒ **Kept**

☐ **Not kept**

Information about measurement uncertainty is on page 31.

Comments:



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Revision: 1.3

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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 17 of 32

## 5. Measurement of radiated emission

according to EN 55022 Class B

Procedure of radiated emission measurement:

- ☒ Scan with max-peak detector in 3 m CDC
- ☒ Final CISPR measurement with quasi peak detector on 10m OATS.

### Location of measurement

Description	Manufacturer	Inventory No.
Compact Diagnostic Chamber	Albatross Projects	E00026
Open Area Test Site	EMV <b>TESTHAUS</b> GmbH	E00354

### Measurement equipment

	Description	Manufacturer	Inventory No.
<input checked="" type="checkbox"/>	ESCS 30 (OATS)	Rohde & Schwarz	E00003
<input checked="" type="checkbox"/>	ESCI (CDC)	Rohde & Schwarz	E00001
<input type="checkbox"/>	ESU26	Rohde & Schwarz	W00002
<input checked="" type="checkbox"/>	VULB 9163 (OATS)	Schwarzbeck	E00013
<input checked="" type="checkbox"/>	VULB 9160 (CDC)	Schwarzbeck	E00011
<input type="checkbox"/>	MDS 20	Rohde & Schwarz	E00132
<input type="checkbox"/>	MDS 21	Rohde & Schwarz	E00010

Test related measurement inaccuracies have to be taken into consideration when evaluating the test results.  
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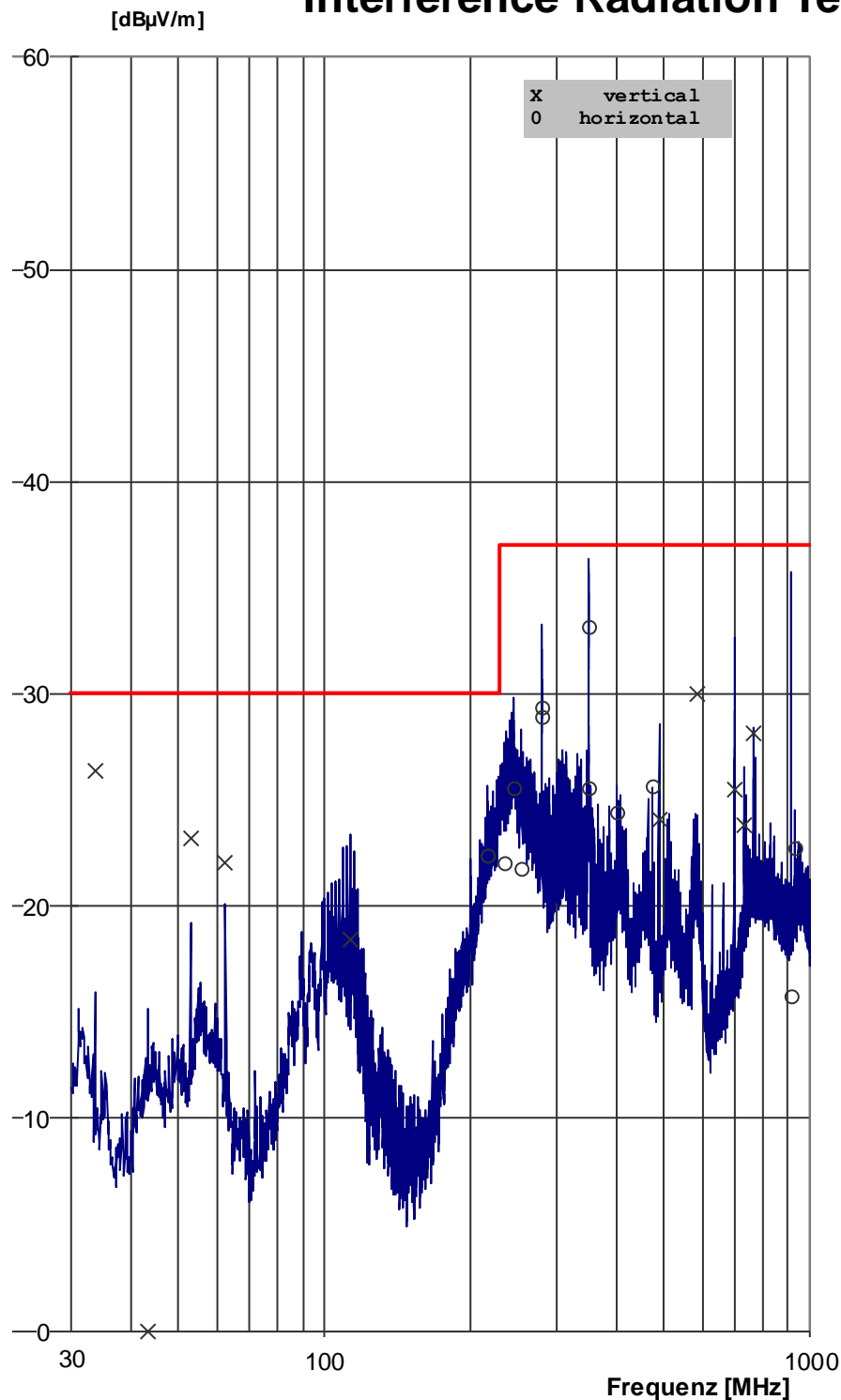
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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 18 of 32

# Interference Radiation Test



## REGULATIONS:

EN 55022 Class B  
PEAK / CISPR

## TEST EQUIPMENT:

R&S ESCS30 (E00003)  
VULB 9163 (E00013)

## ORDER NO.:

120276-AU01+E01

## EUT:

Identive Technologies India  
Pvt., Ltd.  
EMC test for Contact Card  
Reader CE, FCC + IC, VCCI,,  
ACMA

## OPERATION MODE:

Continuously reading

## TEST FACILITY:

EMV TESTHAUS GmbH  
Gustav-Hertz-Straße 35  
94315 Straubing

## DATE / TIME:

2012-11-08  
8°C 42% 97kPa

## TEST ENGINEER:

Fabian Schmidt

120276-AU01+E01 CDC 01.E10

Picture 7: Measurement report of radiated emission



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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 19 of 32

# Interference Radiation Test

Freq. [MHz]	U_Rec [dBµV/m]	Limit [dBµV/m]	Corr. [dB]	U_Ant. [dBµV]	delta_U [dB]	Turn- table	Antenna	Pol.	Remark
									120276-AU01+E01 CDC 01 E10
33,60	26,4	30,0	12,6	13,8	3,6	18°	100 cm	V	
43,20	0,0	30,0	14,6	-14,6	30,0	0°	100 cm	V	
52,80	23,2	30,0	14,6	8,7	6,8	182°	128 cm	V	
62,40	22,0	30,0	13,0	9,0	8,0	86°	100 cm	V	
112,80	18,4	30,0	6,3	12,1	11,6	95°	100 cm	V	
216,00	22,4	30,0	13,1	9,2	7,6	48°	255 cm	H	
233,70	22,1	37,0	14,1	8,0	14,9	190°	250 cm	H	
244,50	25,6	37,0	10,5	15,2	11,4	104°	100 cm	H	
253,90	21,7	37,0	14,4	7,4	15,3	282°	250 cm	H	
278,80	29,3	37,0	14,7	14,7	7,7	299°	374 cm	H	
279,90	29,0	37,0	10,3	18,7	8,0	116°	100 cm	H	
348,70	33,2	37,0	11,8	21,4	3,8	83°	112 cm	H	
349,30	25,6	37,0	16,9	8,6	11,5	73°	250 cm	H	
400,00	24,4	37,0	18,4	6,0	12,6	73°	250 cm	H	
473,20	25,6	37,0	19,6	6,1	11,4	154°	250 cm	H	
487,90	24,1	37,0	13,7	10,4	12,9	127°	100 cm	V	
583,00	30,0	37,0	22,0	8,1	7,0	230°	100 cm	V	
697,00	25,5	37,0	14,8	10,7	11,5	85°	100 cm	V	
731,90	23,8	37,0	23,5	0,3	13,2	335°	138 cm	V	
766,70	28,2	37,0	24,1	4,1	8,8	137°	100 cm	V	
911,00	15,8	37,0	19,2	-3,4	21,2	27°	100 cm	H	
930,00	22,8	37,0	26,8	-4,0	14,2	312°	245 cm	H	

Picture 8: Frequency table of radiated emission



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CLOUD 2700 F

120276-AU01+E01

Page 20 of 32

## Photo documentation



Picture 9: Test setup of radiated emission



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CLOUD 2700 F

120276-AU01+E01

Page 21 of 32

## Test result

The requirements according to EN 55022 Class B are

☒ **Kept**

☐ **Not kept**

Information about measurement uncertainty is on page 31.

Comments:



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CLOUD 2700 F

120276-AU01+E01

Page 22 of 32

## 6. Electrostatic discharge immunity test

according to EN 61000-4-2

### Location of measurement

Description	Manufacturer	Inventory No.
Shielded chamber	Siemens - Matsushita	E00107

### Measurement equipment

	Description	Manufacturer	Inventory No.
<input type="checkbox"/>	ESD 3000	EMC Partner	E00040
<input checked="" type="checkbox"/>	NSG 435	Teseq	E00412
<input checked="" type="checkbox"/>	VCP	EMV <b>TESTHAUS</b> GmbH	E00047
<input checked="" type="checkbox"/>	HCP	EMV <b>TESTHAUS</b> GmbH	E00048

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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 23 of 32

## Test conditions

### Air discharge

Test voltage:	<input checked="" type="checkbox"/> 2 kV	test level 1
	<input checked="" type="checkbox"/> 4 kV	test level 2
	<input checked="" type="checkbox"/> 8 kV	test level 3
	<input type="checkbox"/> 15 kV	test level 4
	<input type="checkbox"/> kV	test level x

Polarity:	<input checked="" type="checkbox"/> positive
	<input checked="" type="checkbox"/> negative

Discharges:	≥ 10 discharges per polarity
-------------	------------------------------

Discharging points:	Card slot
---------------------	-----------

### Contact discharge

Test voltage:	<input checked="" type="checkbox"/> 2 kV	test level 1
	<input checked="" type="checkbox"/> 4 kV	test level 2
	<input type="checkbox"/> 6 kV	test level 3
	<input type="checkbox"/> 8 kV	test level 4
	<input type="checkbox"/> kV	test level x

Polarity:	<input checked="" type="checkbox"/> positive
	<input checked="" type="checkbox"/> negative

Discharges:	≥ 25 discharges per polarity
-------------	------------------------------

Discharging points:	direct:	USB shield
	indirect:	HCP, VCP

Climatic conditions:	Ambient temp.:	20 °C
	Relative humidity.:	41 %
	Barometric pressure:	96,8 kPa



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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 24 of 32



## Photo documentation



Picture 10: Test setup ESD

## Test result

The requirements according to EN 61000-4-2 are

- ☒ **Kept**
- ☐ **Not kept**

Information about measurement uncertainty is on page 31.

### Operating conditions during test:

#### Criterion

- ☒ **A** The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- ☐ **B** After the test, the equipment shall continue to operate as intended without operator invention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- ☐ **C** Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Comments: During the test the function of the EUT was observed. Influences in any form or program interruptions did not occur.



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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 26 of 32

## 7. Radiated, radio-frequency, electromagnetic field immunity test

according to EN 61000-4-3

### Location of measurement

Description	Manufacturer	Inventory No.
Anechoic chamber	EMV <b>TESTHAUS</b> GmbH	E00100

### Measurement equipment

	Model	Description	Manufacturer	Inventory
<input checked="" type="checkbox"/>	SMT06	Signal Generator	Rohde & Schwarz	E00036
<input checked="" type="checkbox"/>	BTA 0122-150W	Amplifier 9 kHz-220 MHz	Bonn	E00071
<input checked="" type="checkbox"/>	BLWA 2010-100W	Amplifier 200-1000 MHz	Bonn	E00072
<input type="checkbox"/>	AS0104-55/30	Amplifier 1 - 4GHz	Milmega	E00070
<input checked="" type="checkbox"/>	VULB 9163	Antenna 30 – 3000 MHz	Schwarzbeck	E00012
<input type="checkbox"/>	HL 023 A	Antenna 80 – 1300 MHz	Rohde & Schwarz	E00027
<input type="checkbox"/>	BBHA 9120E	Antenne 1000 – 2700 MHz	Schwarzbeck	E00018
<input checked="" type="checkbox"/>	COSF 3312	Power Switching Unit	Conformitas	E00037
<input checked="" type="checkbox"/>	NRVD	Power Meter	Rohde & Schwarz	E00038
<input checked="" type="checkbox"/>	NRV-Z51	Power Measuring Head	Rohde & Schwarz	E00075
<input checked="" type="checkbox"/>	NRV-Z51	Power Measuring Head	Rohde & Schwarz	E00076

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Revision: 1.3

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USB Contact Card Reader  
CLOUD 2700 F

120276-AU01+E01

Page 27 of 32

# Test Conditions

Frequency range: ☒ 80 MHz - 1000 MHz  
☐ 1400 MHz - 2000 MHz  
☐ 2000 MHz - 2700 MHz

Step size: ☒ 1 % of output frequency  
☐ 4 % of output frequency

Field strength: ☐ 1 V/m test level 1  
☒ 3 V/m test level 2  
☐ 10 V/m test level 3  
☐ V/m test level x

Modulation: Kind of Modulation: AM  
Modulation factor: 80 %  
Modulation frequency: 1 kHz

Dwell time: ☒ 3 seconds  
☐ X seconds

Antenna polarization: ☒ vertical  
☒ horizontal

Test distance: ☐ 1 m  
☒ 3 m

EUT position: ☒ front side  
☒ rear side  
☒ left side  
☒ right side  
☐ top  
☐ bottom

Observation of EUT: Via video camera

Climatic conditions: Ambient temp.: 19 °C  
Relative humidity.: 43 %  
Barometric pressure: 96,8 kPa



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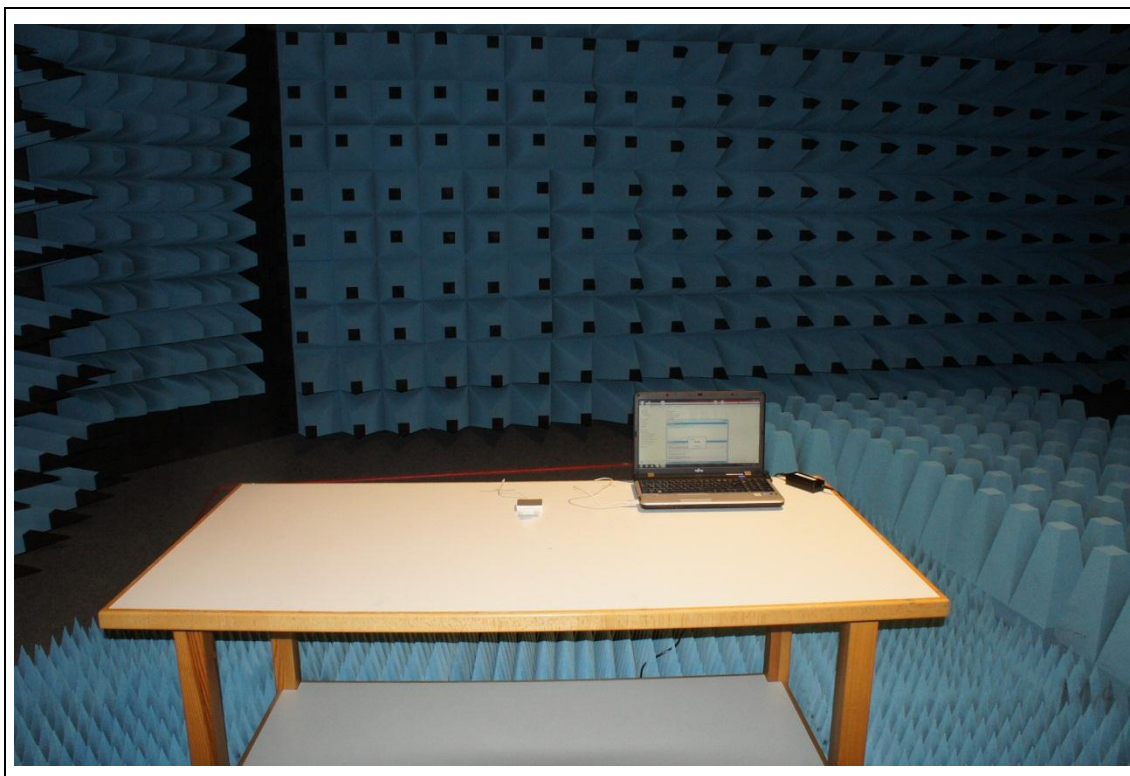
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Page 28 of 32

## Photo documentation



Picture 11: Test setup of radiated immunity test

## Test result

The requirements according to EN 61000-4-3 are

- ☒ **Kept**
- ☐ **Not Kept**

Information about measurement uncertainty is on page 31.

### Operating conditions during test:

#### Criterion

- ☒ **A** The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- ☐ **B** After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
- ☐ **C** Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Comments: During the test the function of the EUT was observed. Influences in any form or program interruptions did not occur.



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Page 30 of 32

## 8. Measurement uncertainty

Standard	Description	Max. deviation	k=
EN 55022	Conducted emission AMN (150kHz to 30 MHz)	+/- 4,1 dB	2
EN 55022	Radiated emission open field (30 MHz to 300 MHz) (300MHz to 1 GHz)	+/- 5,4 dB +/- 4,7 dB	2
EN 61000-4-2	ESD	inside specification *	
EN 61000-4-3	Radiated immunity	+/- 1,8 dB <sup>a.)</sup>	1,64

Comment: The uncertainty stated is the expanded uncertainty obtained by multiplying the standard uncertainty by the coverage factor k. If k=2 the value of the measurands lies within the assigned range of values with a probability of 95 %.

\*

a.)

The specific requirements regarding to the standard was kept

To maintain the claimed test level with a probability of 90 % an additional test level of 38 % percent must be added.



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Page 31 of 32

## 9. Summary

The EMC regulations according to the marked specifications are


☒ **Kept**

The Equipment under Test fulfills the general approval requirements mentioned.

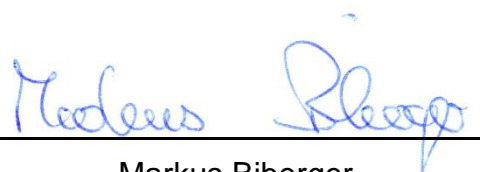
☐ **Not kept**

The Equipment under Test does not fulfill the general approval requirements mentioned.

Straubing, November 8<sup>th</sup>, 2012



Fabian Schmidt  
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EMV **TESTHAUS** GmbH



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Page 32 of 32